imall

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Power MOSFET

9.0 A, 52 V, N–Channel, Logic Level, Clamped MOSFET w/ESD Protection in a DPAK Package

Benefits

- High Energy Capability for Inductive Loads
- Low Switching Noise Generation

Features

- Diode Clamp Between Gate and Source
- ESD Protection HBM 5000 V
- Active Over–Voltage Gate to Drain Clamp
- Scalable to Lower or Higher R_{DS(on)}
- Internal Series Gate Resistance
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

• Automotive and Industrial Markets: Solenoid Drivers, Lamp Drivers, Small Motor Drivers

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Rating	Symbol	Value	Unit		
Drain-to-Source Voltage Internally Clamped	V _{DSS}	52–59	V		
Gate-to-Source Voltage - Continuous	V _{GS}	±15	V		
Drain Current – Continuous @ $T_A = 25^{\circ}C$ – Single Pulse ($t_p = 10 \ \mu s$)	I _D I _{DM}	9.0 35	A		
Total Power Dissipation @ $T_A = 25^{\circ}C$	PD	1.74	W		
Operating and Storage Temperature Range	T _J , T _{stg}	-55 to 175	°C		
Single Pulse Drain-to-Source Avalanche Energy – Starting T _J = 125°C (V _{DD} = 50 V, I _{D(pk)} = 1.5 A, V _{GS} = 10 V, $R_G = 25 \Omega$)	E _{AS}	160	mJ		
Thermal Resistance, Junction-to-Case Junction-to-Ambient (Note 1) Junction-to-Ambient (Note 2)	$f{R}_{ heta JC} \ f{R}_{ heta JA} \ f{R}_{ heta JA}$	5.2 72 100	°C/W		
Maximum Lead Temperature for Soldering Purposes, 1/8" from Case for 10 seconds	ΤL	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

When surface mounted to a FR4 board using 1" pad size, (Cu area 1.127 in²).
 When surface mounted to a FR4 board using minimum recommended pad

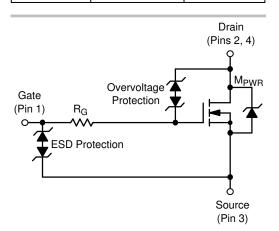
size, (Cu area 0.412 in²).

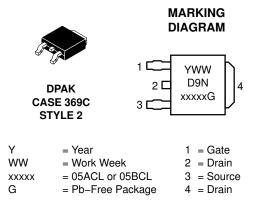


ON Semiconductor®

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V _{DSS} (Clamped)	R _{DS(ON)} TYP	I _D MAX (Limited)
52 V	90 mΩ	9.0 A





ORDERING INFORMATION

Device	Package	Shipping [†]
NID9N05ACLT4G	DPAK (Pb–Free)	2500/Tape & Reel
NID9N05BCLT4G	DPAK (Pb–Free)	2500/Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

C	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS		_				
Drain-to-Source Breakdown Voltage (Note 3) ($V_{GS} = 0 V$, $I_D = 1.0 mA$, $T_J = 25^{\circ}C$) ($V_{GS} = 0 V$, $I_D = 1.0 mA$, $T_J = -40^{\circ}C$ to 125°C) Temperature Coefficient (Negative)			52 50.8 -	55 54 –10	59 59.5 –	V V mV/°C
Zero Gate Voltage Drain Curren (V _{DS} = 40 V, V _{GS} = 0 V) (V _{DS} = 40 V, V _{GS} = 0 V, T _J =		I _{DSS}	-		10 25	μΑ
$\begin{array}{l} \mbox{Gate-Body Leakage Current} \\ (V_{GS}=\pm 8 \mbox{ V, } V_{DS}=0 \mbox{ V)} \\ (V_{GS}=\pm 14 \mbox{ V, } V_{DS}=0 \mbox{ V)} \end{array}$		I _{GSS}			±10 _	μΑ
ON CHARACTERISTICS (Note	3)					
$\begin{array}{l} Gate \mbox{ Threshold Voltage (Note 3 \\ (V_{DS} = V_{GS}, \mbox{ I}_{D} = 100 \ \mu A) \\ \mbox{ Threshold Temperature Coefficient} \end{array}$		V _{GS(th)}	1.3 _	1.75 -4.5	2.5 -	V mV/°C
Static Drain-to-Source On-Resistance (Note 3) $(V_{GS} = 4.0 \text{ V}, I_D = 1.5 \text{ A})$ $(V_{GS} = 3.5 \text{ V}, I_D = 0.6 \text{ A})$ $(V_{GS} = 3.0 \text{ V}, I_D = 0.2 \text{ A})$ $(V_{GS} = 12 \text{ V}, I_D = 9.0 \text{ A})$ $(V_{GS} = 12 \text{ V}, I_D = 12 \text{ A})$			- - 70 67	153 175 _ 90 95	181 364 1210 – –	mΩ
Forward Transconductance (No	te 3) (V _{DS} = 15 V, I _D = 9.0 A)	9 FS	-	24	-	Mhos
DYNAMIC CHARACTERISTICS	3			1	L	
Input Capacitance		C _{iss}	-	155	250	pF
Output Capacitance	(V _{DS} = 40 V, V _{GS} = 0 V, f = 10 kHz)	C _{oss}	-	60	100	
Transfer Capacitance		C _{rss}	-	25	40	
Input Capacitance		C _{iss}	-	175	-	pF
Output Capacitance	(V _{DS} = 25 V, V _{GS} = 0 V, f = 10 kHz)	C _{oss}	-	70	-	
Transfer Capacitance		C _{rss}	-	30	-	
SWITCHING CHARACTERISTI	CS (Note 4)					
Turn-On Delay Time		t _{d(on)}	-	130	200	ns
Rise Time	(V _{GS} = 10 V, V _{DD} = 40 V,	t _r	-	500	750	
Turn–Off Delay Time	$I_{\rm D} = 9.0 \text{ A}, \text{ R}_{\rm G} = 9.0 \Omega$	t _{d(off)}	-	1300	2000	
Fall Time		t _f	_	1150	1850	
Turn-On Delay Time		t _{d(on)}	-	200	-	ns
Rise Time	(V _{GS} = 10 V, V _{DD} = 15 V,	t _r	-	500	-	
Turn-Off Delay Time	$I_{D} = 1.5 \text{ A}, \text{ R}_{G} = 2 \text{ k}\Omega)$	t _{d(off)}	-	2500	-	
Fall Time		t _f	-	1800	-	
Turn-On Delay Time		t _{d(on)}	-	120	-	ns
Rise Time	(V _{GS} = 10 V, V _{DD} = 15 V,	t _r	_	275	_	
Turn-Off Delay Time	$I_{\rm D} = 1.5 \rm A, R_{\rm G} = 50 \Omega)$	t _{d(off)}	_	1600	_	
Fall Time		t _f	_	1100	-	
Gate Charge		QT	_	4.5	7.0	nC
	(V _{GS} = 4.5 V, V _{DS} = 40 V, I _D = 9.0 A) (Note 3)	Q ₁	_	1.2	_	
	_ /、 /	Q ₂	-	2.7	-	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise noted)

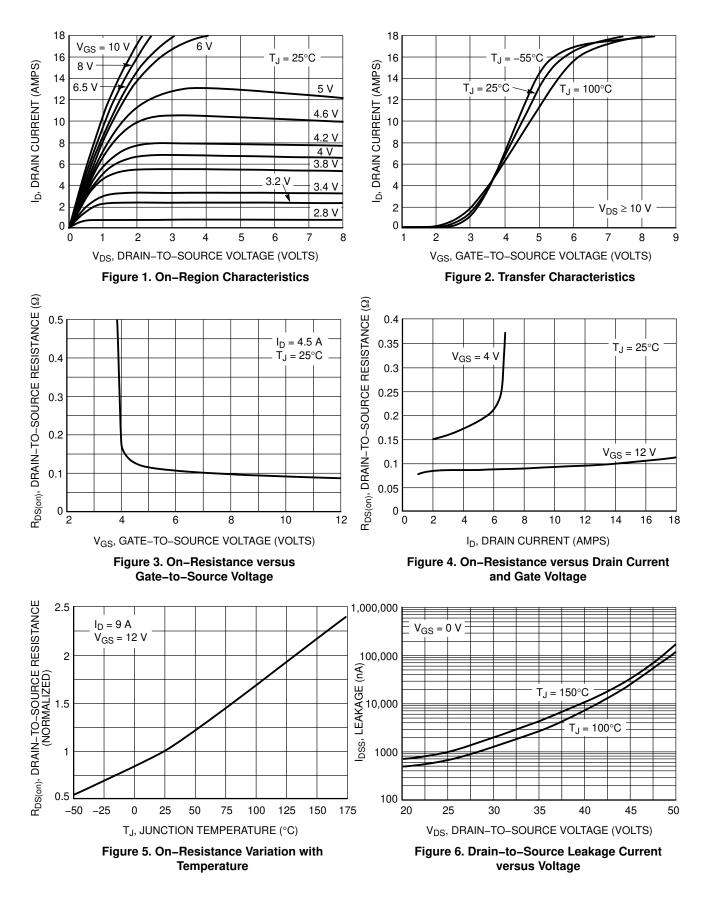
	Symbol	Min	Тур	Max	Unit	
SWITCHING CHARACTERIS	TICS (Note 4)				•	•
Gate Charge		Q _T	-	3.6	-	nC
	(V _{GS} = 4.5 V, V _{DS} = 15 V, I _D = 1.5 A) (Note 3)	Q ₁	-	1.0	-	
		Q ₂	-	2.0	-	
SOURCE-DRAIN DIODE CH	ARACTERISTICS					
Forward On–Voltage		V _{SD}	- - -	0.86 0.845 0.725	1.2 - -	V
Reverse Recovery Time		t _{rr}	-	700	-	ns
	(I _S = 4.5 A, V _{GS} = 0 V, dl _s /dt = 100 A/us) (Note 3)	ta	-	200	-	
		t _b	-	500	-	
Reverse Recovery Stored Cha	arge	Q _{RR}	-	6.5	-	μC
ESD CHARACTERISTICS						
Electre Ctetic Discharge	Liveran Dark Madal (LDM)	FOD	F000			× 1

Electro-Static Discharge Capability	Human Body Model (HBM)	ESD	5000	-	-	V	
Capability	Machine Model (MM)		500	-	-		

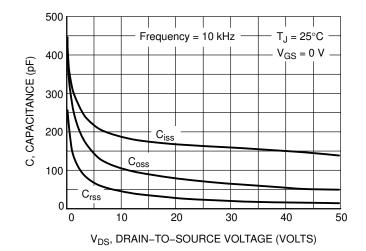
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

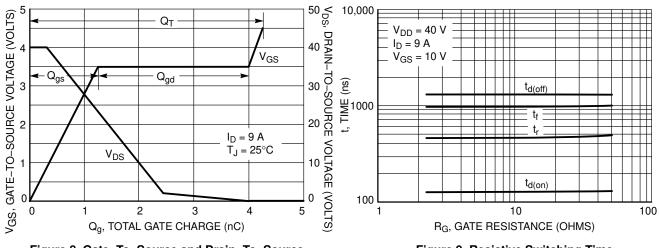
TYPICAL PERFORMANCE CURVES



TYPICAL PERFORMANCE CURVES







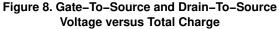
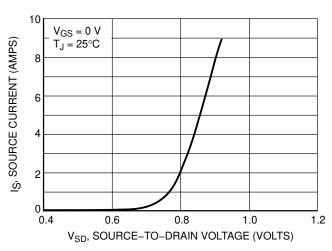
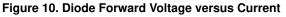


Figure 9. Resistive Switching Time Variation versus Gate Resistance



DRAIN-TO-SOURCE DIODE CHARACTERISTICS



SAFE OPERATING AREA

The Forward Biased Safe Operating Area curves define the maximum simultaneous drain-to-source voltage and drain current that a transistor can handle safely when it is forward biased. Curves are based upon maximum peak junction temperature and a case temperature (T_C) of 25°C. Peak repetitive pulsed power limits are determined by using the thermal response data in conjunction with the procedures discussed in AN569, "Transient Thermal Resistance – General Data and Its Use."

Switching between the off-state and the on-state may traverse any load line provided neither rated peak current (I_{DM}) nor rated voltage (V_{DSS}) is exceeded and the transition time (t_r, t_f) do not exceed 10 µs. In addition the total power averaged over a complete switching cycle must not exceed (T_{J(MAX)} – T_C)/(R_{θJC}).

A Power MOSFET designated E–FET can be safely used in switching circuits with unclamped inductive loads. For reliable operation, the stored energy from circuit inductance dissipated in the transistor while in avalanche must be less than the rated limit and adjusted for operating conditions differing from those specified. Although industry practice is to rate in terms of energy, avalanche energy capability is not a constant. The energy rating decreases non–linearly with an increase of peak current in avalanche and peak junction temperature.

Although many E–FETs can withstand the stress of drain–to–source avalanche at currents up to rated pulsed current (I_{DM}), the energy rating is specified at rated continuous current (I_D), in accordance with industry custom. The energy rating must be derated for temperature as shown in the accompanying graph (Figure 12). Maximum energy at currents below rated continuous I_D can safely be assumed to equal the values indicated.

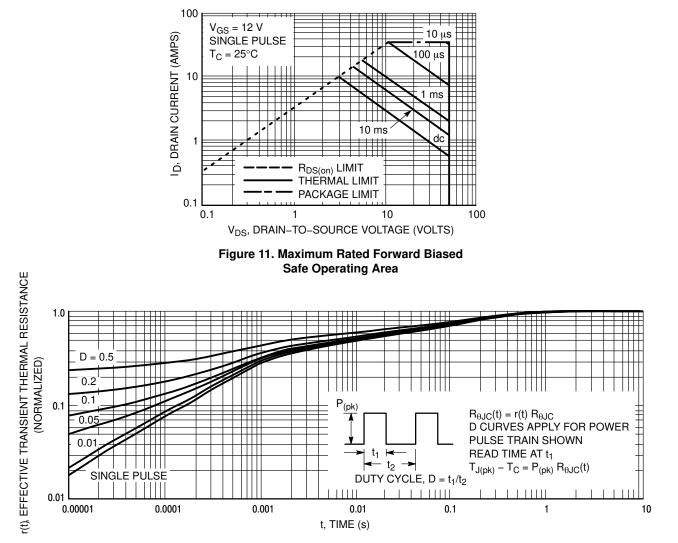
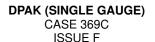
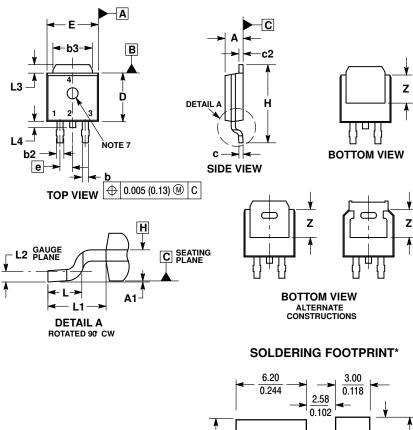


Figure 12. Thermal Response

PACKAGE DIMENSIONS

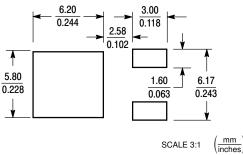




NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DI-3
- MENSIONS b3, L3 and Z.
 DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS, MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- 5. DIMENSIONS D AND E ARE DETERMINED AT THE
- OUTERMOST EXTREMES OF THE PLASTIC BODY. 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H. 7. OPTIONAL MOLD FEATURE.

	INCHES		INCHES MILL		MILLIN	IMETERS	
DIM	MIN	MAX	MIN	MAX			
Α	0.086	0.094	2.18	2.38			
A1	0.000	0.005	0.00	0.13			
b	0.025	0.035	0.63	0.89			
b2	0.028	0.045	0.72	1.14			
b3	0.180	0.215	4.57	5.46			
c	0.018	0.024	0.46	0.61			
c2	0.018	0.024	0.46	0.61			
D	0.235	0.245	5.97	6.22			
Е	0.250	0.265	6.35	6.73			
e	0.090) BSC	2.29 BSC				
Н	0.370	0.410	9.40	10.41			
L	0.055	0.070	1.40	1.78			
L1	0.114	REF	2.90	REF			
L2	0.020) BSC	0.51 BSC				
L3	0.035	0.050	0.89	1.27			
L4		0.040		1.01			
Ζ	0.155		3.93				



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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